

CE EMC TEST REPORT

REPORT NO.: CP150407D11A

TEST MODEL: GT-46400-3612-T3, GT-46400-4015-T3,
GT-46400-4019-T3, GT-46400-4024-T3

SERIES MODEL: GT-46400-WWVV-X.X-TZ
(WW is the standard output wattage, with a maximum value of "40", VV is the standard rated output voltage designation, with a value of "12" "15" "19" and "24";
-X.X denote the output voltage differentiator, subtracting X.X volts from standard output voltage VV in 0.1V increments, the actual output voltage range is 12-24V, blank is to indicate the no voltage different.
Z can be 3 or 3A, 3 means C14 inlet type, 3A means C6 inlet type)

RECEIVED: Apr. 7, 2015

TESTED: Apr. 9 ~ 13, 2015

ISSUED: Aug. 11, 2015

APPLICANT: GLOBTEK, INC

ADDRESS: 186 Veterans Dr. Northvale, NJ07647 USA

ISSUED BY: Bureau Veritas Consumer Products Services (H.K.)
Ltd., Taoyuan Branch

LAB LOCATION: No. 47-2, 14th Ling, Chia Pau Vil., Lin Kou Dist., New
Taipei City, Taiwan (R.O.C)

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RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
CP150407D11A	Original release	Aug. 11, 2015

1 CERTIFICATION

PRODUCT: Switching-Mode Power Supply

TEST MODEL: GT-46400-3612-T3, GT-46400-4015-T3, GT-46400-4019-T3, GT-46400-4024-T3

SERIES MODEL: GT-46400-WWVV-X.X-TZ (WW is the standard output wattage, with a maximum value of "40", VV is the standard rated output voltage designation, with a value of "12" "15" "19" and "24";
-X.X denote the output voltage differentiator, subtracting X.X volts from standard output voltage VV in 0.1V increments, the actual output voltage range is 12-24V, blank is to indicate the no voltage different. Z can be 3 or 3A, 3 means C14 inlet type, 3A means C6 inlet type)

TEST ITEM: ENGINEERING SAMPLE

APPLICANT: GLOBTEK, INC

TESTED: Apr. 9 ~ 13, 2015

STANDARDS: EN 61204-3: 2000, Class B	EN 55022:2010 +AC:2011, Class B
Emission:	CISPR 22:2008, Class B
CISPR 22:2008, Class B	AS/NZS CISPR 22:2009 +A1:2010, Class B
IEC 61000-3-2:2014 ED.4.0	EN 61000-3-2:2014
IEC 61000-3-3:2013 ED.3.0	EN 61000-3-3:2013
Immunity:	EN 55024:2010
IEC 61000-4-2:2008 ED.2.0	IEC 61000-4-2:2008 ED.2.0
IEC 61000-4-3:2010 ED.3.2	IEC 61000-4-3:2010 ED.3.2
IEC 61000-4-4:2012 ED.3.0	IEC 61000-4-4:2012 ED.3.0
IEC 61000-4-5:2005 ED.2.0	IEC 61000-4-5:2005 ED.2.0
IEC 61000-4-6:2013 ED.4.0	IEC 61000-4-6:2013 ED.4.0
IEC 61000-4-11:2004 ED.2.0	IEC 61000-4-8:2009 ED.2.0
	IEC 61000-4-11:2004 ED.2.0

The above equipment have been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by : Sandra Lin , Date: Aug. 11, 2015
Sandra Lin / Specialist

Approved by : Henry Lai , Date: Aug. 11, 2015
Henry Lai / Director

2 SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specifications:

EMISSION			
Standard	Test Type	Result	Remarks
EN 55022:2010 +AC:2011, Class B CISPR 22:2008, Class B	Conducted Test	PASS	Meets Class B Limit Minimum passing margin is -7.12 dB at 0.18516 MHz
AS/NZS CISPR 22: 2009 +A1:2010, Class B	Radiated Test (30MHz to 1GHz)	PASS	Meets Class B Limit Minimum passing margin is -8.29 dB at 30.53 MHz
IEC 61000-3-2:2014 ED.4.0/ EN 61000-3-2:2014	Harmonic current emissions	PASS	The power consumption of EUT is less than 75W and no limits apply.
IEC 61000-3-3: 2013 ED.3.0/ EN 61000-3-3: 2013	Voltage fluctuations & flicker	PASS	Meets the requirements.

Note: The EUT highest frequency generated below 108MHz and therefore the test frequency range was performed for 30MHz to 1GHz for radiated emission test.



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IMMUNITY (EN 61204-3: 2000) & (EN 55024: 2010)			
Standard	Test Type	Result	Remarks
IEC 61000-4-2:2008 ED.2.0	Electrostatic discharge immunity test	PASS	Meets the requirements of Performance Criterion A
IEC 61000-4-3:2010 ED.3.2	Radiated, radio-frequency, electromagnetic field immunity test	PASS	Meets the requirements of Performance Criterion A
IEC 61000-4-4: 2012 ED.3.0	Electrical fast transient / burst immunity test.	PASS	Meets the requirements of Performance Criterion A
IEC 61000-4-5:2005 ED.2.0	Surge immunity test	PASS	Meets the requirements of Performance Criterion A
IEC 61000-4-6:2013 ED.4.0	Immunity to conducted disturbances, induced by radio-frequency fields	PASS	Meets the requirements of Performance Criterion A
IEC 61000-4-8:2009 ED.2.0 (for EN 55024 only)	Power frequency magnetic field immunity test.	PASS	Meets the requirements of Performance Criterion A
IEC 61000-4-11:2004 ED.2.0 (for EN 61204-3)	Voltage dips, short interruptions and voltage variations immunity tests	PASS	Meets the requirements of Voltage Dips: i).30% reduction - Performance Criterion A ii).60% reduction – Performance Criterion B Voltage Interruptions: i).>95% reduction – Performance Criterion B
IEC 61000-4-11:2004 ED.2.0 (for EN 55024)	Voltage dips, short interruptions and voltage variations immunity tests	PASS	Meets the requirements of Voltage Dips: i). >95% reduction - Performance Criterion A ii). 30% reduction – Performance Criterion A Voltage Interruptions: i). >95% reduction – Performance Criterion B

2.1 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

MEASUREMENT	UNCERTAINTY
Conducted emissions	+/- 3.43 dB
Radiated emissions	+/- 4.26 dB

The listed uncertainties are the worst case uncertainty for the entire range of measurement. Please note that the uncertainty values are provided for informational purposes only and are not used in determining the PASS/FAIL results.

3 GENERAL INFORMATION

3.1 GENERAL DESCRIPTION OF EUT

PRODUCT	Switching-Mode Power Supply
TEST MODEL	GT-46400-3612-T3, GT-46400-4015-T3, GT-46400-4019-T3, GT-46400-4024-T3
SERIES MODEL	GT-46400-WWVV-X.X-TZ (WW is the standard output wattage, with a maximum value of "40", VV is the standard rated output voltage designation, with a value of "12" "15" "19"and "24"; -X.X denote the output voltage differentiator, subtracting X.X volts from standard output voltage VV in 0.1V increments, the actual output voltage rang is 12-24V, blank is to indicate the no voltage different. Z can be 3 or 3A, 3 means C14 inlet type, 3A means C6 inlet type)
POWER SUPPLY	Switching Rating: refer to Note below Power Cord: Non-shielded DC (1.15 m) with one ferrite core
DATA CABLE SUPPLIED	N/A

NOTE:

1. The EUT is a Switching Power Supply (AC 3-pin) and it has several models, which are identical to each other except for following:

Model No.		AC I/P	DC O/P
GT-46400-WWVV-X.X-TZ (WW is the standard output wattage, with a maximum value of "40", VV is the standard rated output voltage designation, with a value of "12" "15" "19"and "24"; -X.X denote the output voltage differentiator, subtracting X.X volts from standard output voltage VV in 0.1V increments, the actual output voltage rang is 12-24V, blank is to indicate the no voltage different. Z can be 3 or 3A, 3 means C14 inlet type, 3A means C6 inlet type)	GT-46400-3012-T3	100-240Vac, 50-60Hz, 1.0A	12V/ 2.5A
	GT-46400-3015-T3		15V/ 2A
	GT-46400-3019-T3		19V/ 1.57A
	GT-46400-3024-T3		24V/ 1.25A
	GT-46400-3612-T3		12V/ 3A
	GT-46400-4015-T3		15V/ 2.66A
	GT-46400-4019-T3		19V/ 2.1A
	GT-46400-4024-T3		24V/ 1.66A

During the test, the Model No.: GT-46400-3612-T3, GT-46400-4015-T3, GT-46400-4019-T3, GT-46400-4024-T3 were selected as the representative one for the test and therefore only its test data were recorded in this report.

2. For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

3.2 DESCRIPTION OF TEST MODES

1. The EUT is designed with AC power of rating 100-240Vac, 50-60Hz. For radiated emission evaluation, 230Vac/50Hz (for EN 55022), 120Vac/60Hz (for FCC Part 15), had been covered during the pre-test. The worst data was found at **230Vac/50Hz** and recorded in the applied test report.
2. Above four models have been pre-tested, and test **model no.: GT-46400-4019-T3** was the worst case. Therefore test modes are presented in the report as below.

Test Item	Test Mode	Model No.	Input Power
Conducted Emission Test	Mode 1	GT-46400-3612-T3	230V/50Hz
	Mode 2	GT-46400-4015-T3	
	Mode 3	GT-46400-4019-T3	
	Mode 4	GT-46400-4024-T3	
Radiated Emission, Harmonic, Flicker & Immunity Tests	Mode 3	GT-46400-4019-T3	

3.3 GENERAL DESCRIPTION OF APPLIED STANDARDS

The EUT is a SWITCH-MODE POWER SUPPLY, which are intended for sale to an end-users or installer. Therefore, according to the specifications of the manufacturers, must comply with the requirements of the following standards:

EN 61204-3:2000, Class B

Emission:

CISPR 22:2008, Class B

IEC 61000-3-2:2014 ED.4.0

IEC 61000-3-3:2013 ED.3.0

Immunity:

IEC 61000-4-2:2008 ED.2.0

IEC 61000-4-3:2010 ED.3.2

IEC 61000-4-4:2012 ED.3.0

IEC 61000-4-5:2005 ED.2.0

IEC 61000-4-6:2013 ED.4.0

IEC 61000-4-11:2004 ED.2.0

EN 55022:2010 +AC:2011, Class B

CISPR 22:2008, Class B

**AS/NZS CISPR 22:2009 +A1:2010,
Class B**

EN 61000-3-2: 2014

EN 61000-3-3: 2013

EN 55024:2010

IEC 61000-4-2:2008 ED.2.0

IEC 61000-4-3:2010 ED.3.2

IEC 61000-4-4:2012 ED.3.0

IEC 61000-4-5:2005 ED.2.0

IEC 61000-4-6:2013 ED.4.0

IEC 61000-4-8:2009 ED.2.0

IEC 61000-4-11:2004 ED.2.0

Notes: The above IEC basic standards are applied with latest version if customer has no special requirement

3.4 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

3.4.1 FOR EMISSION TEST

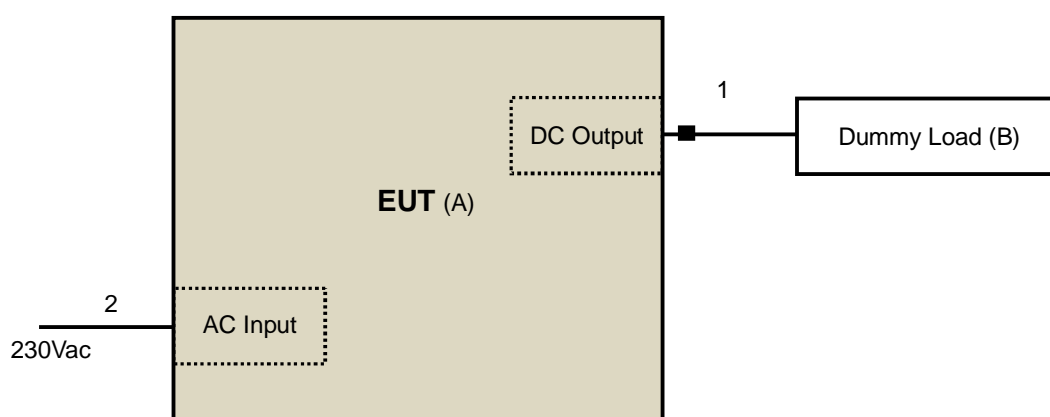
ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	EUT	-	GT-46400-3612-T3	-	-	-
			GT-46400-4015-T3	-	-	-
			GT-46400-4019-T3	-	-	-
			GT-46400-4024-T3	-	-	-
B.	DUMMY LOAD	BVADT	L19B	L2-010025	N/A	Provided by Lab

Note: All power cords of the above support units are non-shielded (1.8m).

ID	Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DC cable	1	1.15	N	1	Supplied by client
2.	AC power cord	1	1.8	N	0	Provided by Lab

Note: The core(s) is(are) originally attached to the cable(s).

Test Configuration



3.4.2 FOR HARMONICS, FLICKER & IMMUNITY TEST

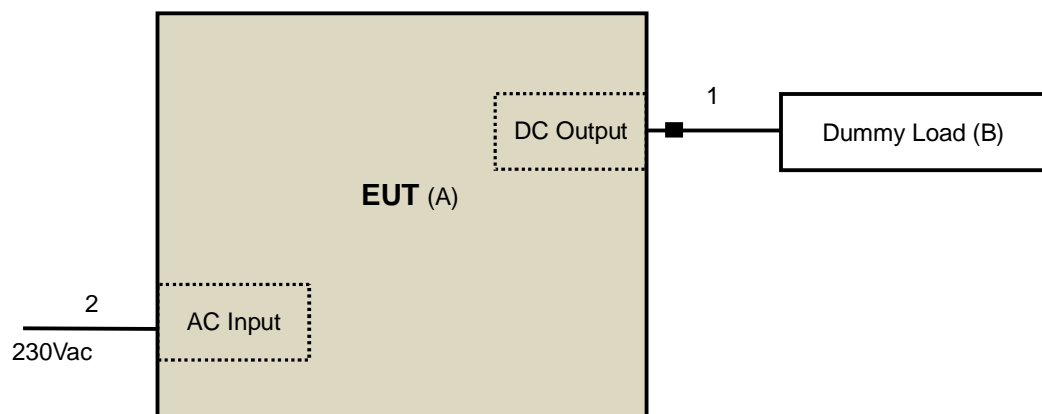
ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	EUT	-	GT-46400-4019-T3	-	-	-
B.	DUMMY LOAD	ADT	L19A	L2-010014	N/A	Provided by Lab
C.	Multimeter	YFE	YF-370A	N/A	N/A	Provided by Lab

Note: All power cords of the above support units are non-shielded (1.8m).

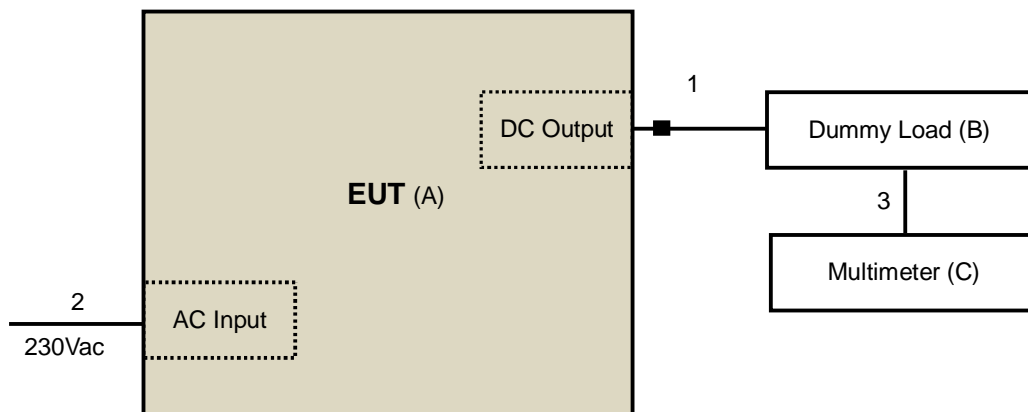
ID	Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DC cable	1	1.15	N	1	Supplied by client
2.	AC power cord	1	1.8	N	0	Provided by Lab
3.	Data cable	1	0.6	N	0	Provided by Lab

Note: The core(s) is(are) originally attached to the cable(s).

TEST CONFIGURATION – Harmonic & Flicker Test



TEST CONFIGURATION – Immunity Test



4 EMISSION TEST

4.1 CONDUCTED EMISSION MEASUREMENT

4.1.1 LIMITS OF CONDUCTED EMISSION MEASUREMENT

TEST STANDARD: EN 55022 / EN 61204-3

FREQUENCY (MHz)	Class A (dBuV)		Class B (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	79	66	66 - 56	56 - 46
0.50 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

- NOTE:** (1) The lower limit shall apply at the transition frequencies.
 (2) The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

4.1.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	100292	Dec. 18, 2014	Dec. 17, 2015
ROHDE & SCHWARZ Artificial Mains Network (for EUT)	ESH2-Z5	100104	Dec. 04, 2014	Dec. 03, 2015
LISN With Adapter (for EUT)	AD10	C09Ada-001	Dec. 04, 2014	Dec. 03, 2015
ROHDE & SCHWARZ Artificial Mains Network (for peripherals)	ESH3-Z5	847265/023	Oct. 21, 2014	Oct. 20, 2015
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 08, 2014	May 07, 2015
Software	ADT_Cond_ V7.3.7	NA	NA	NA
RF cable (JYEBAO)	5D-FB	Cable-C09.01	Feb. 24, 2015	Feb. 23, 2016
SUHNTER Terminator (For ROHDE & SCHWARZ LISN)	65BNC-5001	E1-010789	May 20, 2014	May 19, 2015
ROHDE & SCHWARZ Artificial Mains Network (For TV EUT)	ESH3-Z5	100220	Nov. 20, 2014	Nov. 19, 2015
LISN With Adapter (for TV EUT)	100220	N/A	Nov. 20, 2014	Nov. 19, 2015

- Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 2. The test was performed in Shielded Room No. 9.
 3. The VCCI Site Registration No. C-1312.
 4. Tested Date: Apr. 9, 2015.

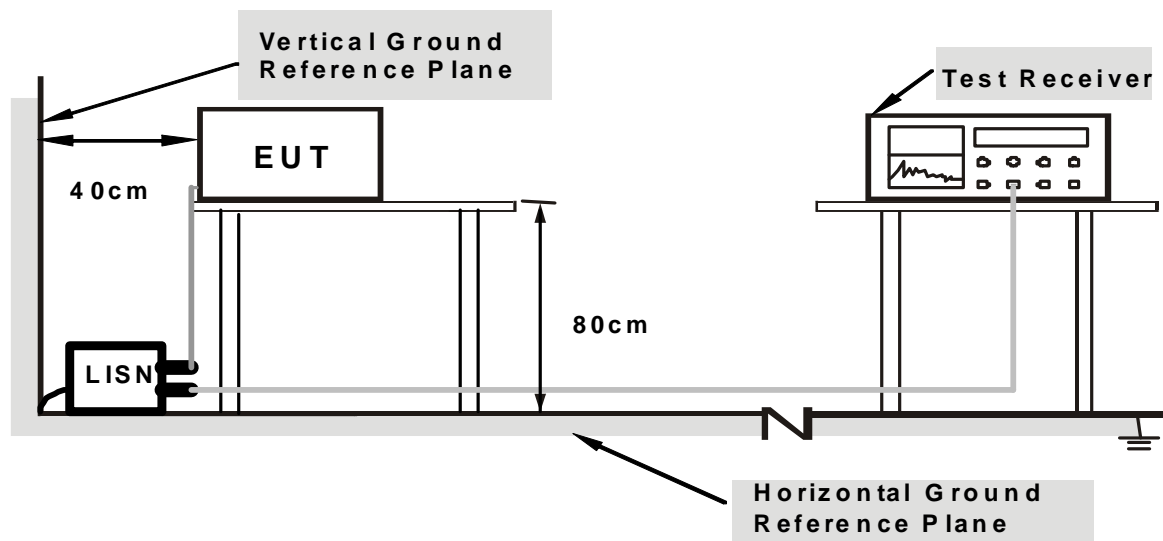
4.1.3 TEST PROCEDURE

- The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- The frequency range from 150 kHz to 30 MHz was searched. Emission levels under (Limit -20dB) were not recorded.

4.1.4 DEVIATION FROM TEST STANDARD

No deviation

4.1.5 TEST SETUP



Note: Support units were connected to second LISN.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

4.1.6 EUT OPERATING CONDITIONS

Set the EUT under full resistor load.

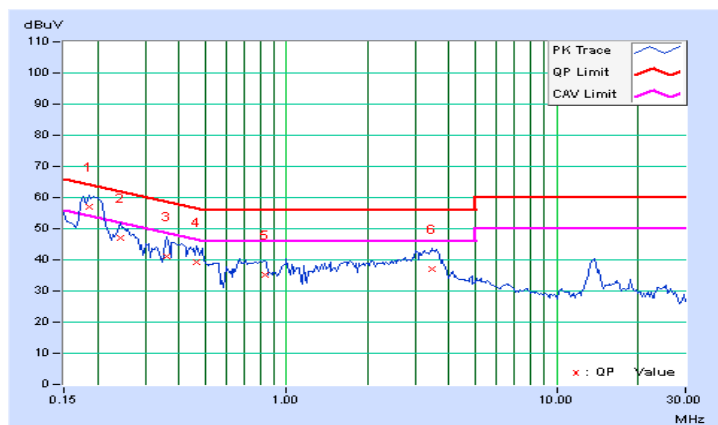
4.1.7 TEST RESULTS (1)

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	23°C, 74%RH
Tested by	Paul Chen		
Test Mode	Mode 1		

Phase Of Power : Line (L)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.18516	0.22	56.92	39.99	57.14	40.21	64.25	54.25	-7.12	-14.05
2	0.24375	0.23	46.95	29.00	47.18	29.23	61.97	51.97	-14.79	-22.74
3	0.36094	0.26	40.92	23.35	41.18	23.61	58.71	48.71	-17.53	-25.10
4	0.46250	0.28	38.97	23.26	39.25	23.54	56.65	46.65	-17.40	-23.11
5	0.82969	0.34	34.99	19.65	35.33	19.99	56.00	46.00	-20.67	-26.01
6	3.45703	0.53	36.46	21.92	36.99	22.45	56.00	46.00	-19.01	-23.55

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

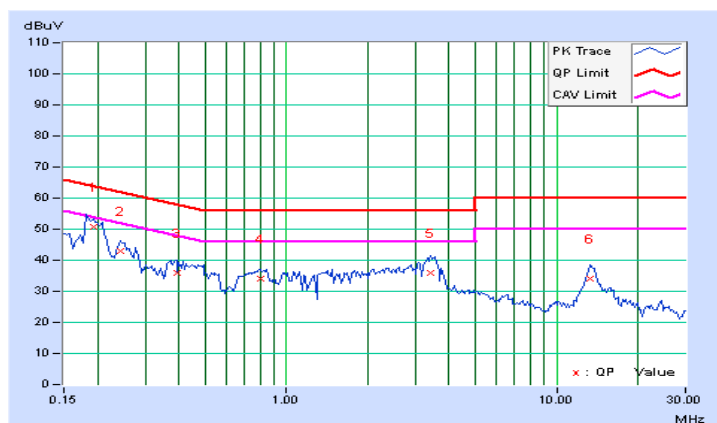


Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	23°C, 74%RH
Tested by	Paul Chen		
Test Mode	Mode 1		

Phase Of Power : Neutral (N)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBUV)		Emission Level (dBUV)		Limit (dBUV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.19297	0.23	50.69	34.79	50.92	35.02	63.91	53.91	-12.99	-18.89
2	0.24375	0.24	42.69	25.18	42.93	25.42	61.97	51.97	-19.04	-26.55
3	0.39219	0.28	35.51	20.07	35.79	20.35	58.02	48.02	-22.23	-27.67
4	0.80625	0.35	33.56	18.80	33.91	19.15	56.00	46.00	-22.09	-26.85
5	3.42578	0.54	35.45	20.84	35.99	21.38	56.00	46.00	-20.01	-24.62
6	13.38281	0.82	33.08	24.38	33.90	25.20	60.00	50.00	-26.10	-24.80

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



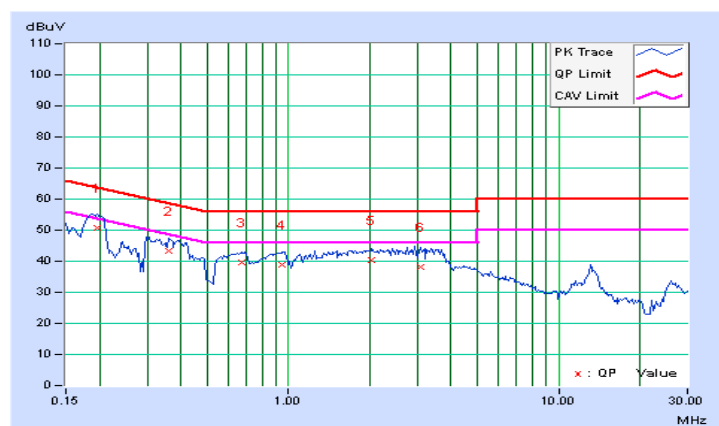
4.1.8 TEST RESULTS (2)

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	23°C, 74%RH
Tested by	Paul Chen		
Test Mode	Mode 2		

Phase Of Power : Line (L)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.19687	0.22	50.55	36.93	50.77	37.15	63.74	53.74	-12.97	-16.59
2	0.36094	0.26	42.91	28.27	43.17	28.53	58.71	48.71	-15.54	-20.18
3	0.66953	0.31	39.20	24.55	39.51	24.86	56.00	46.00	-16.49	-21.14
4	0.95078	0.36	38.51	22.19	38.87	22.55	56.00	46.00	-17.13	-23.45
5	2.03125	0.46	39.73	26.98	40.19	27.44	56.00	46.00	-15.81	-18.56
6	3.08594	0.51	37.74	25.67	38.25	26.18	56.00	46.00	-17.75	-19.82

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

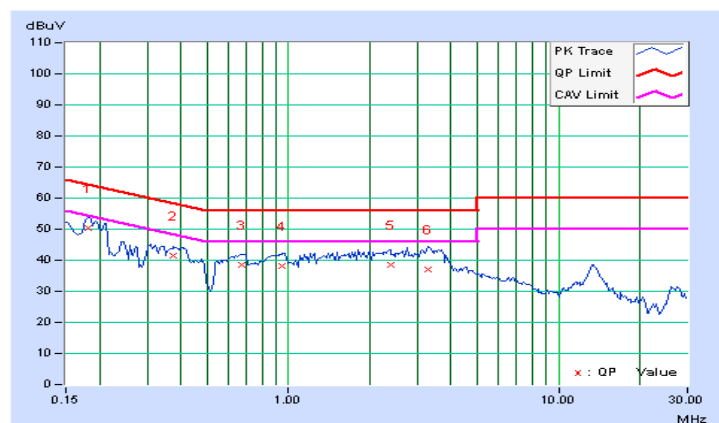


Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	23°C, 74%RH
Tested by	Paul Chen		
Test Mode	Mode 2		

Phase Of Power : Neutral (N)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.18125	0.22	50.31	36.16	50.53	36.38	64.43	54.43	-13.90	-18.05
2	0.37656	0.27	41.13	27.05	41.40	27.32	58.35	48.35	-16.95	-21.03
3	0.66953	0.32	38.29	23.79	38.61	24.11	56.00	46.00	-17.39	-21.89
4	0.94688	0.37	37.82	21.34	38.19	21.71	56.00	46.00	-17.81	-24.29
5	2.38281	0.49	38.07	24.79	38.56	25.28	56.00	46.00	-17.44	-20.72
6	3.30469	0.54	36.57	24.30	37.11	24.84	56.00	46.00	-18.89	-21.16

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



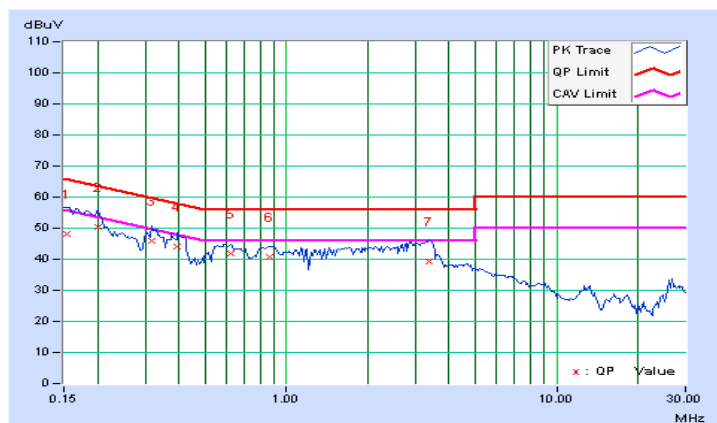
4.1.9 TEST RESULTS (3)

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	23°C, 74%RH
Tested by	Paul Chen		
Test Mode	Mode 3		

Phase Of Power : Line (L)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15391	0.21	47.98	19.68	48.19	19.89	65.79	55.79	-17.60	-35.90
2	0.20078	0.22	50.33	36.79	50.55	37.01	63.58	53.58	-13.03	-16.57
3	0.31797	0.25	45.78	32.09	46.03	32.34	59.76	49.76	-13.73	-17.42
4	0.39609	0.27	43.86	28.70	44.13	28.97	57.93	47.93	-13.81	-18.97
5	0.62266	0.31	41.48	28.13	41.79	28.44	56.00	46.00	-14.21	-17.56
6	0.86094	0.35	40.22	25.37	40.57	25.72	56.00	46.00	-15.43	-20.28
7	3.38672	0.53	38.79	25.93	39.32	26.46	56.00	46.00	-16.68	-19.54

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

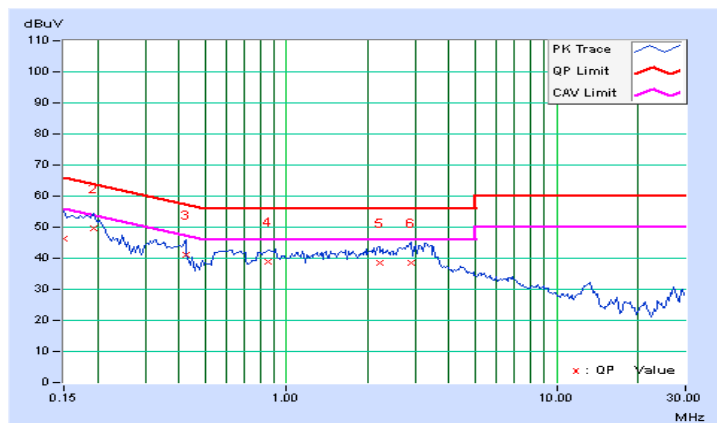


Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	23°C, 74%RH
Tested by	Paul Chen		
Test Mode	Mode 3		

Phase Of Power : Neutral (N)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBUV)		Emission Level (dBUV)		Limit (dBUV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15000	0.21	46.16	19.96	46.37	20.17	66.00	56.00	-19.63	-35.83
2	0.19297	0.23	49.39	36.20	49.62	36.43	63.91	53.91	-14.29	-17.48
3	0.42344	0.28	40.99	25.07	41.27	25.35	57.38	47.38	-16.11	-22.03
4	0.85313	0.36	38.42	24.18	38.78	24.54	56.00	46.00	-17.22	-21.46
5	2.20703	0.48	37.91	24.34	38.39	24.82	56.00	46.00	-17.61	-21.18
6	2.91016	0.52	37.91	25.39	38.43	25.91	56.00	46.00	-17.57	-20.09

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



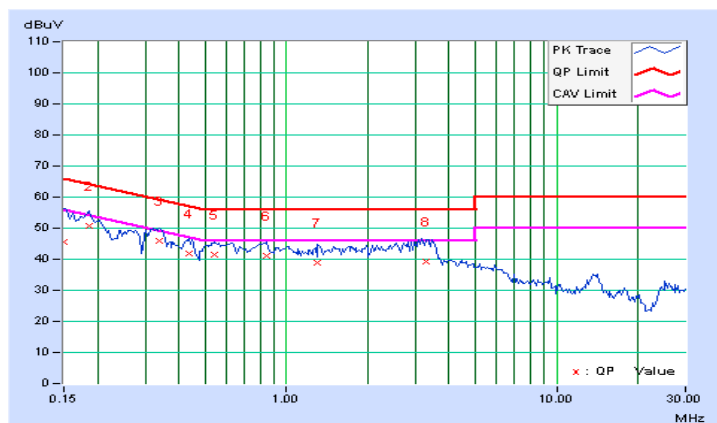
4.1.10 TEST RESULTS (4)

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	23°C, 74%RH
Tested by	Paul Chen		
Test Mode	Mode 4		

Phase Of Power : Line (L)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15000	0.20	45.53	20.52	45.73	20.72	66.00	56.00	-20.27	-35.28
2	0.18516	0.21	50.67	35.28	50.88	35.49	64.25	54.25	-13.37	-18.76
3	0.33750	0.24	45.55	31.11	45.79	31.35	59.26	49.26	-13.48	-17.92
4	0.43516	0.25	41.51	23.89	41.76	24.14	57.15	47.15	-15.39	-23.01
5	0.54453	0.27	41.07	27.83	41.34	28.10	56.00	46.00	-14.66	-17.90
6	0.84922	0.30	40.85	27.02	41.15	27.32	56.00	46.00	-14.85	-18.68
7	1.30078	0.34	38.63	22.17	38.97	22.51	56.00	46.00	-17.03	-23.49
8	3.28906	0.44	38.73	25.65	39.17	26.09	56.00	46.00	-16.83	-19.91

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

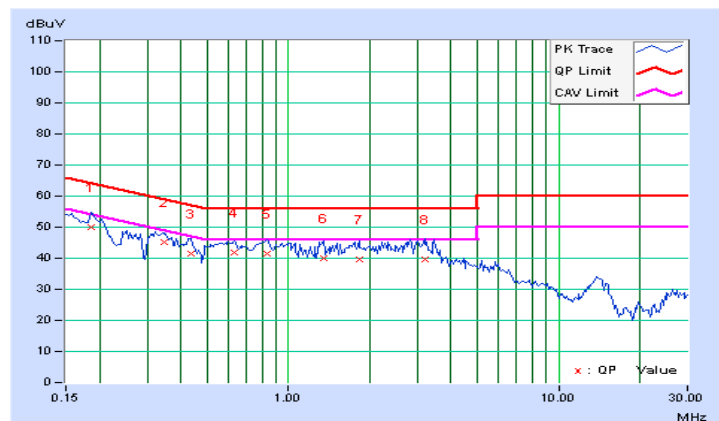


Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	23°C, 74%RH
Tested by	Paul Chen		
Test Mode	Mode 4		

Phase Of Power : Neutral (N)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.18516	0.21	49.77	35.48	49.98	35.69	64.25	54.25	-14.27	-18.56
2	0.34531	0.25	45.07	30.54	45.32	30.79	59.07	49.07	-13.76	-18.29
3	0.43516	0.26	41.25	23.51	41.51	23.77	57.15	47.15	-15.64	-23.38
4	0.62656	0.29	41.69	27.45	41.98	27.74	56.00	46.00	-14.02	-18.26
5	0.83750	0.31	41.01	26.07	41.32	26.38	56.00	46.00	-14.68	-19.62
6	1.34766	0.35	39.50	25.52	39.85	25.87	56.00	46.00	-16.15	-20.13
7	1.82422	0.39	39.36	26.06	39.75	26.45	56.00	46.00	-16.25	-19.55
8	3.19531	0.44	39.18	26.28	39.62	26.72	56.00	46.00	-16.38	-19.28

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



4.2 RADIATED EMISSION MEASUREMENT

4.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT

TEST STANDARD: EN 55022 / EN 61204-3

FOR FREQUENCY BELOW 1000 MHz

FREQUENCY (MHz)	Class A (at 10m)	Class B (at 10m)
	dBuV/m	dBuV/m
30 – 230	40	30
230 – 1000	47	37

TEST STANDARD: EN 55022

FOR FREQUENCY ABOVE 1000 MHz

FREQUENCY (GHz)	Class A (dBuV/m) (at 3m)		Class B (dBuV/m) (at 3m)	
	PEAK	AVERAGE	PEAK	AVERAGE
1 to 3	76	56	70	50
3 to 6	80	60	74	54

- NOTE:** (1) The lower limit shall apply at the transition frequencies.
 (2) Emission level (dBuV/m) = 20 log Emission level (uV/m).
 (3) All emanation from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

FREQUENCY RANGE OF RADIATED MEASUREMENT (For unintentional radiators)

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement Range (MHz)
Below 108	1000
108 – 500	2000
500 – 1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less

4.2.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Preamplifier	8447D	2944A11062	Feb. 27, 2015	Feb. 26, 2016
Agilent Preamplifier	8447D	2944A11064	Feb. 27, 2015	Feb. 26, 2016
Agilent Test Receiver	N9038A	MY50010158	Jul. 22, 2014	Jul. 21, 2015
Agilent Test Receiver	N9038A	MY51210114	Dec. 09, 2014	Dec. 08, 2015
Schwarzbeck Antenna	VULB9168	9168-316	Feb. 06, 2015	Feb. 05, 2016
Schwarzbeck Antenna	VULB9168	9168-317	Feb. 06, 2015	Feb. 05, 2016
Max Full. Turn Table & Tower	MF7802	MF7802121	NA	NA
Max Full. Tower	MF7802	MF780208105	NA	NA
Software	ADT_Radiated_V8.7.07	NA	NA	NA
WOKEN RF cable	8D	CABLE-CH8-01.V	Dec. 17, 2014	Dec. 16, 2015
JYE BAO RF cable	8D	CABLE-CH8-02.H	Dec. 17, 2014	Dec. 16, 2015
JYE BAO RF cable	8D	CABLE-CH8-03.3M	Dec. 17, 2014	Dec. 16, 2015

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in Chamber No. 8.
3. The Industry Canada Reference No. IC 7450E-8.
4. The VCCI Site Registration No. R-2946.
5. The FCC Site Registration No. 493821.
6. Tested Date: Apr. 9, 2015.

4.2.3 TEST PROCEDURE

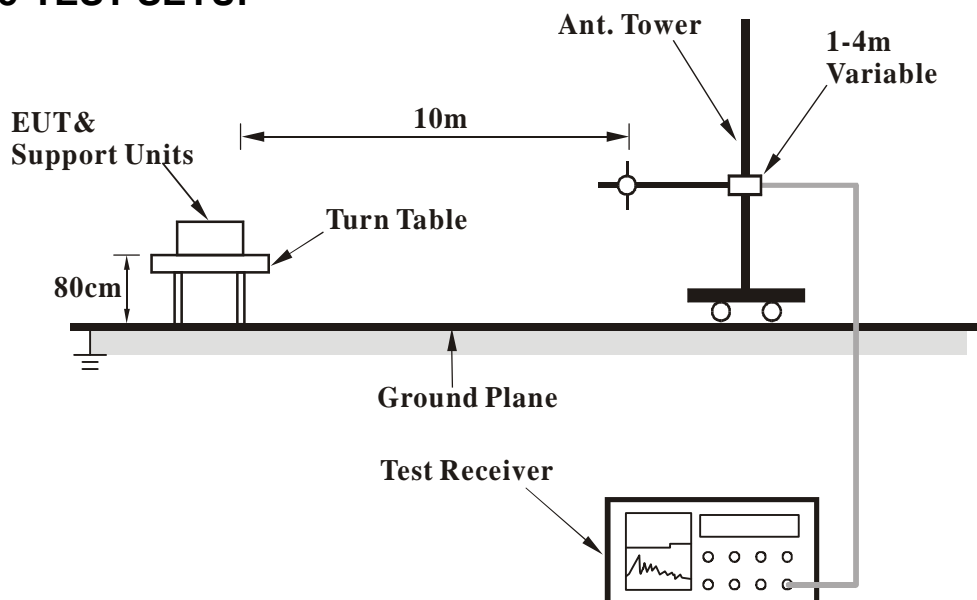
- The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10-meter Semi-anechoic chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the turn table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.

NOTE: The resolution bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection (QP) at frequency below 1GHz.

4.2.4 DEVIATION FROM TEST STANDARD

No deviation

4.2.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

4.2.6 EUT OPERATING CONDITIONS

Same as item 4.1.6.

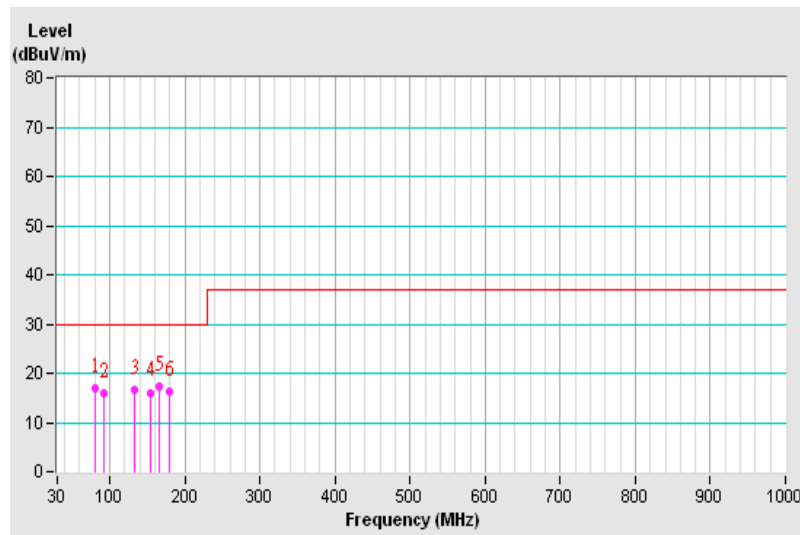
4.2.7 TEST RESULTS

Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Bruce Lee	Environmental Conditions	22°C, 75%RH
Test Mode	Mode 3		

Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	81.12	16.82 QP	30.00	-13.18	4.00 H	180	34.04	-17.22
2	92.18	15.79 QP	30.00	-14.21	3.50 H	38	33.77	-17.98
3	132.72	16.52 QP	30.00	-13.48	4.00 H	49	29.47	-12.95
4	154.84	16.10 QP	30.00	-13.90	3.00 H	292	27.76	-11.66
5	166.28	17.18 QP	30.00	-12.82	3.00 H	327	29.06	-11.88
6	179.14	16.12 QP	30.00	-13.88	3.50 H	228	28.96	-12.84

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
– Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value

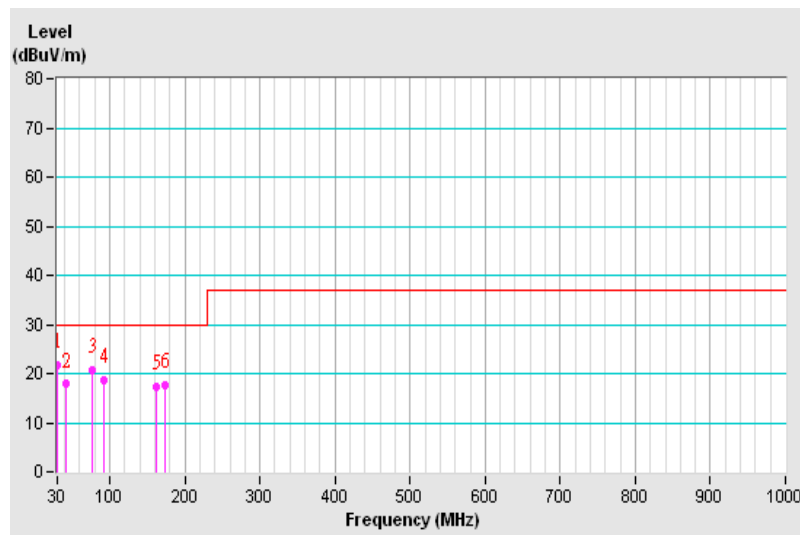


Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Bruce Lee	Environmental Conditions	22°C, 75%RH
Test Mode	Mode 3		

Antenna Polarity & Test Distance : Vertical at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	30.53	21.71 QP	30.00	-8.29	1.00 V	125	36.27	-14.56
2	42.27	17.88 QP	30.00	-12.12	1.50 V	137	30.71	-12.83
3	76.56	20.66 QP	30.00	-9.34	1.00 V	152	36.36	-15.70
4	92.18	18.79 QP	30.00	-11.21	1.00 V	217	36.25	-17.46
5	161.39	17.34 QP	30.00	-12.66	2.00 V	58	28.53	-11.19
6	172.98	17.73 QP	30.00	-12.27	1.50 V	71	29.34	-11.61

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
– Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value



4.3 HARMONICS CURRENT MEASUREMENT

4.3.1 LIMITS OF HARMONICS CURRENT MEASUREMENT

TEST STANDARD: IEC 61000-3-2 / EN 61000-3-2

Limits for Class A equipment		Limits for Class D equipment		
Harmonics Order n	Max. permissible harmonics current A	Harmonics Order n	Max. permissible harmonics current per watt mAW	Max. permissible harmonics current A
Odd harmonics		Odd Harmonics only		
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
15<=n<=39	0.15x15/n	15<=n<=39	3.85/n	0.15x15/n
Even harmonics				
2	1.08			
4	0.43			
6	0.30			
8<=n<=40	0.23x8/n			

NOTE: 1. Class A and Class D are classified according to section 5 of IEC 61000-3-2/ EN 61000-3-2.

2. According to section 7 of IEC 61000-3-2/ EN 61000-3-2, the above limits for all equipment except for lighting equipment are for all applications having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

4.3.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
EMC PARTNER EMC Emission Tester	HAR1000-1P	084	Apr. 16, 2014	Apr. 15, 2015
Software	HARCS	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 2. The test was performed in EMS Room No. 1.
 3. According to IEC 61000-4-7: 2002, the time window shall be synchronized with each group of 10 or 12 cycles (200 ms) for power frequency of 50 or 60Hz.
 4. Tested Date: Apr. 10, 2015

4.3.3 TEST PROCEDURE

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The classification of EUT is according to section 5 of IEC 61000-3-2: 2005/ EN 61000-3-2: 2006.

The EUT is classified as follows:

Class A: Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.

Class B: Portable tools. ; Arc welding equipment which is not professional equipment

Class C: Lighting equipment.

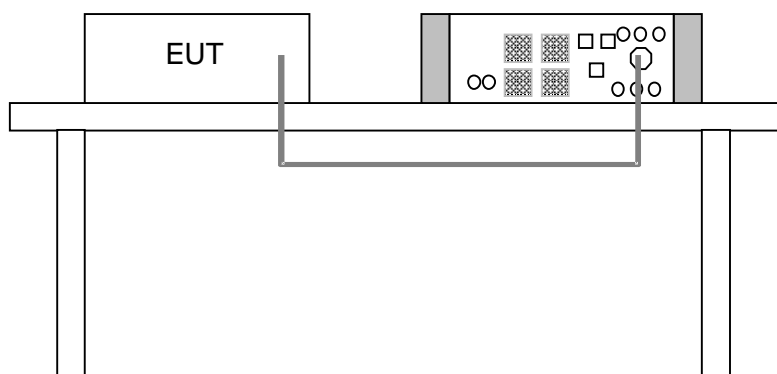
Class D: Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors and television receivers.

- c. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

4.3.4 DEVIATION FROM TEST STANDARD

No deviation

4.3.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

4.3.6 EUT OPERATING CONDITIONS

Connected resistor load to DC output port of EUT to make EUT have maximum power consumption.



A D T

4.3.7 TEST RESULTS

TEST MODE	Mode 3		
FUNDAMENTAL VOLTAGE/AMPERE	230.1Vrms/ 0.437Arms	POWER FREQUENCY	49.987Hz
POWER CONSUMPTION	43.93W	POWER FACTOR	0.437
ENVIRONMENTAL CONDITIONS	25deg. C, 76% RH	TESTED BY: Jiannren Hsieh	

- Note: 1. Limits are not specified for equipment with a rated power of 75W or less (other than lighting equipment).
2. According to EN 61000-3-2 the manufacturer shall specify the power of the apparatus. This value shall be used for establishing limits. The specified power shall be within +/-10% of the measured power.

4.4 VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

4.4.1 LIMITS OF VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

TEST STANDARD: IEC 61000-3-3 / EN 61000-3-3

TEST ITEM	LIMIT	NOTE
P_{st}	1.0	P_{st} means short-term flicker indicator.
P_{lt}	0.65	P_{lt} means long-term flicker indicator.
$T_{d(t)}$ (ms)	500	$T_{d(t)}$ means maximum time that $d(t)$ exceeds 3.3%.
d_{max} (%)	4	d_{max} means maximum relative voltage change.
dc (%)	3.3	dc means relative steady-state voltage change

4.4.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
EMC PARTNER EMC Emission Tester	HAR1000-1P	084	Apr. 16, 2014	Apr. 15, 2015
Software	HARCS	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in EMS Room No. 1.
3. Tested Date: Apr. 10, 2015

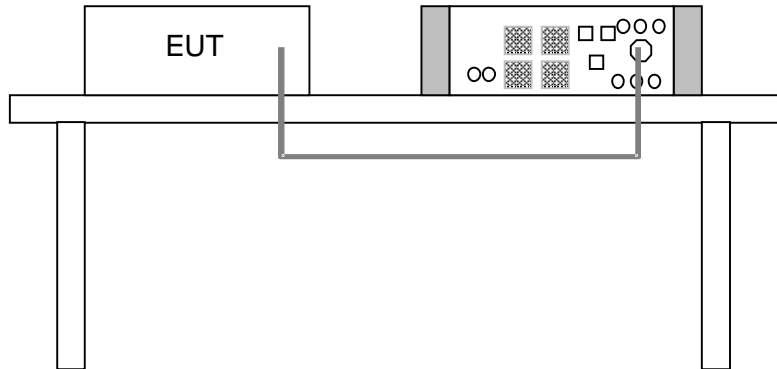
4.4.3 TEST PROCEDURE

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

4.4.4 DEVIATION FROM TEST STANDARD

No deviation

4.4.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

4.4.6 EUT OPERATING CONDITIONS

Same as item 4.3.6

4.4.7 TEST RESULTS

TEST MODE	Mode 3		
FUNDAMENTAL VOLTAGE/AMPERE	230.1Vrms/ 0.437Arms	POWER FREQUENCY	49.987Hz
OBSERVATOPM PERIOD (Tp)	10 min	POWER FACTOR	0.437
ENVIRONMENTAL CONDITIONS	25deg. C, 76% RH	TESTED BY: Jiannren Hsieh	

TEST PARAMETER	MEASUREMENT VALUE	LIMIT	REMARKS
P _{st}	0.072	1.0	Pass
P _{lt}	0.072	0.65	Pass
d(t) (%)	0	3.3	Pass
d _{max} (%)	0	4	Pass
dc (%)	0.020	3.3	Pass

NOTE: (1) P_{st} means short-term flicker indicator.
(2) P_{lt} means long-term flicker indicator.
(3) d(t) means maximum time that not exceeds 500ms.
(4) d_{max} means maximum relative voltage change.
(5) dc means relative steady-state voltage change.

5 IMMUNITY TEST

5.1 GENERAL DESCRIPTION

Product Standard:	EN 61204-3: 2000	
Basic Standard, specification requirement, and Performance Criteria:	IEC 61000-4-2	Electrostatic Discharge – ESD: 8kV air discharge, 4kV Contact discharge, Performance Criterion B
	IEC 61000-4-3	Radio-Frequency Electromagnetic Field Amplitude modulated – RS: 80-1000 MHz, 3V/m, 80% AM (1kHz), Performance Criterion B Radio-Frequency Electromagnetic Field, Keyed carrier: 900+/-5 MHz, 3V/m, 50 % duty cycle, Rep. Frequency 200 Hz, Performance Criterion B
	IEC 61000-4-4	Electrical Fast Transient/Burst - EFT, Power line: 1kV, Signal line: 0.5kV, Performance Criterion B
	IEC 61000-4-5	Surge Immunity Test: 1.2/50 us Open Circuit Voltage, 8 /20 us Short Circuit Current, line to line: 1kV, line to earth: 2kV, Performance Criterion B
	IEC 61000-4-6	Conducted Radio Frequency Disturbances Test – CS: 0.15-80 MHz, 3Vrms, 80% AM, 1kHz, Performance Criterion B
	IEC 61000-4-11	Voltage Dips: i) 30% reduction – 10ms, Performance Criterion B ii) 60% reduction – 100ms, Performance Criterion C Voltage Interruptions: i) >95% reduction – 5000ms, Performance Criterion C



A D T

Product Standard:	EN 55024:2010	
Basic Standard, specification requirement, and Performance Criteria:	IEC 61000-4-2	Electrostatic Discharge – ESD: 8kV air discharge, 4kV Contact discharge, Performance Criterion B
	IEC 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80-1000 MHz, 3V/m, 80% AM (1kHz), Performance Criterion A
	IEC 61000-4-4	Electrical Fast Transient/Burst - EFT AC Power line: 1kV, DC Power line: 0.5kV Signal line: 0.5kV Performance Criterion B
	IEC 61000-4-5	Surge Immunity Test: AC Power Line: line to line 1 kV, line to earth 2kV DC Power Line: Line to earth 0.5kV Performance Criterion B Outdoor Signal line: i) 1 kV without primary protectors, Performance Criteria C ii) 4 kV with primary protectors, Performance Criterion C
	IEC 61000-4-6	Conducted Radio Frequency Disturbances Test – CS: 0.15-80 MHz, 3V, 80% AM, 1kHz, Performance Criterion A
	IEC 61000-4-8	Power Frequency Magnetic Field Test, 50 Hz, 1A/m, Performance Criterion A
	IEC 61000-4-11	Voltage Dips: i) >95% reduction -0.5 period, Performance Criterion B ii) 30% reduction – 25 period, Performance Criterion C Voltage Interruptions: i). >95% reduction – 250 period, Performance Criterion C

5.2 GENERAL PERFORMANCE CRITERIA DESCRIPTION

According to Clause 6.1 of EN 61204-3: 2000 standard, the following describes the general performance criteria.

Performance Criteria	Basic specifications	Remarks
A	No loss of function or performance during the test	Operating as intended within specified tolerance
B	Temporary loss of function or performance during the test Self recoverable	Degradation of performance shall be specified by the manufacturer PSU shall continue to operate as intended after the test
C	Loss of function or performance Not self-recoverable Not damaged	Any re-settable condition allowed including shut-down

According to Clause 7 of EN 55024 standard, the following describes the general performance criteria.

CRITERION A	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
CRITERION B	After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomenon below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state if stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
CRITERION C	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Particular performance criteria

The particular performance criteria which are specified in the normative annexes of EN 55024 take precedence over the corresponding parts of the general performance criteria.

Where particular performance criteria for specific functions are not given, then the general performance criteria shall apply.

5.3 EUT OPERATING CONDITION

Connected a resistor load to DC output port of EUT to make EUT have maximum power consumption and a multimeter was used to monitor voltage of output.

5.4 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

5.4.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Discharge Voltage:	Air Discharge: 2kV/ 4kV/ 8kV (Direct) Contact Discharge: 2kV/ 4kV (Indirect)
Polarity:	Positive & Negative
Number of Discharge:	For EN 55024: Air Discharge: min. 20 times at each test point Contact Discharge: min. 200 times in total For EN 61204-3: 20 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1 second minimum

5.4.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
KeyTek, ESD Simulator	MZ-15/EC	0401299	Sep. 25, 2014	Sep. 24, 2015

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in ESD Room No. 1.
3. Tested Date: Apr. 10, 2015.

5.4.3 TEST PROCEDURE

The discharges shall be applied in two ways: **<For EN 55024>**

a. Contact discharges to the conductive surfaces and coupling planes:

The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

b. Air discharges at slots and apertures and insulating surfaces:

On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

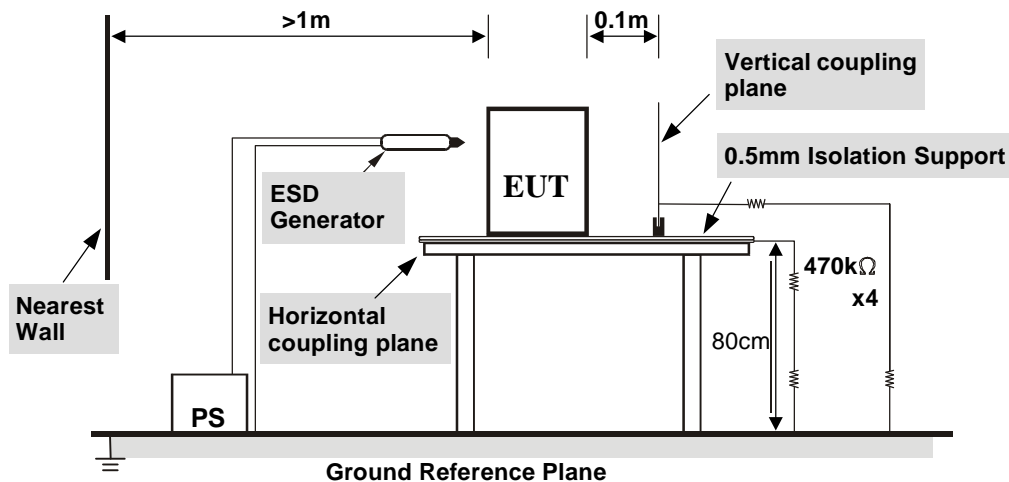
The basic test procedure was in accordance with **IEC 61000-4-2**:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the **Horizontal Coupling Plane** at points on each side of the EUT. The ESD generator was positioned horizontally at a distance of 0.1 meters from the EUT with the discharge electrode touching the **HCP**.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **Vertical Coupling Plane** in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.

5.4.4 DEVIATION FROM TEST STANDARD

No deviation

5.4.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

NOTE:

TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **Ground Reference Plane**. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **Horizontal Coupling Plane** (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940kΩ total impedance. The equipment under test, was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

5.4.6 TEST RESULTS

TEST MODE	Mode 3	INPUT POWER	230Vac, 50Hz
ENVIRONMENTAL CONDITIONS	22 deg. C, 48 % RH, 1013 hPa	TESTED BY: Thomas Cheng	

TEST RESULTS OF DIRECT APPLICATION					
Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criterion
2, 4, 8	+/-	1 ~ 4	N/A	Note	A

Description of test point: Please refer to ESD test photo for representative mark only.

TEST RESULTS OF INDIRECT APPLICATION					
Discharge Level (kV)	Polarity (+/-)	Test Point	Horizontal Coupling Plane	Vertical Coupling Plane	Performance Criterion
2, 4	+/-	1 ~ 4	Note	Note	A

Description of test point:

1. Left side
2. Right side
3. Front side
4. Rear side

NOTE: There was no change compared with initial operation during the test.

5.5 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

5.5.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-3
Frequency Range:	80 MHz - 1000 MHz
Field Strength:	3 V/m
Modulation:	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Polarity of Antenna:	Horizontal and Vertical
Antenna Height:	1.5 m
Dwell Time:	3 seconds

5.5.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Signal Generator	E8257D	MY48050465	Jul. 18, 2014	Jul. 17, 2015
PRANA RF Amplifier	AP32DP280	0811-894	NA	NA
AR RF Amplifier	150W1000M3	306601	NA	NA
AR RF Amplifier	35S4G8AM4	0326094	NA	NA
AR RF Amplifier	100S1G4M3	0329249	NA	NA
AR Controller	SC1000M3	305910	NA	NA
Radisense Electric Field Sensor	CTR1002A	08D00057SNO-07	Oct. 13, 2014	Oct. 12, 2015
BOONTON RF Voltage Meter	4232A	10180	Jun. 04, 2014	Jun. 03, 2015
BOONTON Power Sensor	51011-EMC	34152	Jun. 05, 2014	Jun. 04, 2015
BOONTON Power Sensor	51011-EMC	34153	Jun. 05, 2014	Jun. 04, 2015
AR Log-Periodic Antenna	AT6080	0329465	NA	NA
EMCO BiconiLog Antenna	3141	1001	NA	NA
AR High Gain Antenna	AT4002A	306533	NA	NA
AR High Gain Horn Antenna	AT4010	0329800	NA	NA
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	Feb. 05, 2015	Feb. 04, 2016
Software	ADT_RS_V7.6	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in RS Room No.2.
3. Tested Date: Apr. 13, 2015.

5.5.3 TEST PROCEDURE

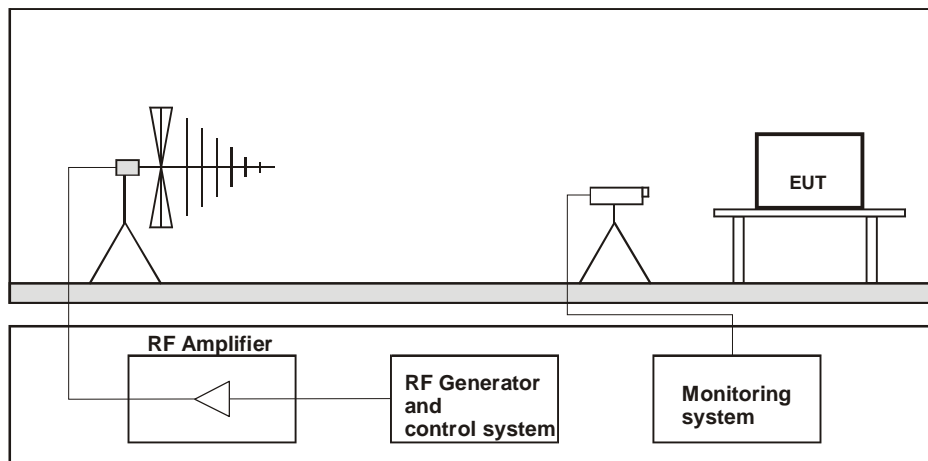
The test procedure was in accordance with IEC 61000-4-3

- The testing was performed in a fully-anechoic chamber.
- The frequency range is swept from 80 MHz to 1000 MHz with the signal 80% amplitude modulated with a 1kHz sine wave.
- The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to respond, but shall in no case be less than 0,5s.
- The field strength level was 3V/m.
- The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

5.5.4 DEVIATION FROM TEST STANDARD

No deviation

5.5.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

NOTE:

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

5.5.6 TEST RESULTS

TEST MODE	Mode 3	INPUT POWER	230Vac, 50Hz
ENVIRONMENTAL CONDITIONS	24 deg. C, 69% RH	TESTED BY: Ken Chen	

Frequency (MHz)	Polarity	Azimuth	Field Strength (V/m)	Observation	Performance Criterion
80 -1000	V & H	0, 90, 180, 270	3	Note	A

NOTE: There was no change compared with initial operation during the test.

5.6 RADIO-FREQUENCY ELECTROMAGNETIC FIELD – KEYED CARRIER TEST

5.6.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-3
Frequency Range:	895 MHz - 905 MHz
Field Strength:	3 V/m
Modulation:	Pulse 200 Hz, 50% Duty Cycle
Frequency Step:	1 MHz
Polarity of Antenna:	Horizontal and Vertical
Antenna Height:	1.5 m
Dwell Time:	3 seconds

5.6.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Signal Generator	E8257D	MY48050465	Jul. 18, 2014	Jul. 17, 2015
PRANA RF Amplifier	AP32DP280	0811-894	NA	NA
AR RF Amplifier	150W1000M3	306601	NA	NA
AR RF Amplifier	35S4G8AM4	0326094	NA	NA
AR RF Amplifier	100S1G4M3	0329249	NA	NA
AR Controller	SC1000M3	305910	NA	NA
Radisense Electric Field Sensor	CTR1002A	08D00057SNO-07	Oct. 13, 2014	Oct. 12, 2015
BOONTON RF Voltage Meter	4232A	10180	Jun. 04, 2014	Jun. 03, 2015
BOONTON Power Sensor	51011-EMC	34152	Jun. 05, 2014	Jun. 04, 2015
BOONTON Power Sensor	51011-EMC	34153	Jun. 05, 2014	Jun. 04, 2015
AR Log-Periodic Antenna	AT6080	0329465	NA	NA
EMCO BiconiLog Antenna	3141	1001	NA	NA
AR High Gain Antenna	AT4002A	306533	NA	NA
AR High Gain Horn Antenna	AT4010	0329800	NA	NA
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	Feb. 05, 2015	Feb. 04, 2016
Software	ADT_RS_V7.6	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in RS Room No.2.
3. Tested Date: Apr. 13, 2015.

5.6.3 TEST PROCEDURE

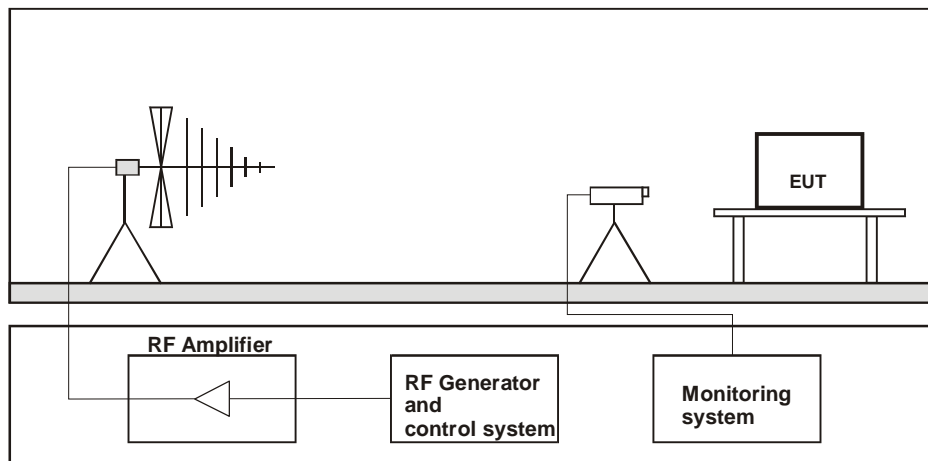
The test procedure was in accordance with IEC 61000-4-3

- The testing was performed in a fully-anechoic chamber.
- The frequency range was from 895 MHz to 905 MHz. The test spot frequencies with keying capability were at 200 Hz, 50 % duty cycle.
- The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond, but shall in no case be less than 0,5s.
- The field strength level was 3V/m.
- The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

5.6.4 DEVIATION FROM TEST STANDARD

No deviation

5.6.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

NOTE:

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

5.6.6 TEST RESULTS

TEST MODE	Mode 3	INPUT POWER	230Vac, 50Hz
ENVIRONMENTAL CONDITIONS	24 deg. C, 69% RH	TESTED BY: Ken Chen	

Frequency (MHz)	Polarity	Azimuth	Field Strength (V/m)	Observation	Performance Criterion
895 -905	V & H	0, 90, 180, 270	3	Note	A

NOTE: There was no change compared with initial operation during the test.

5.7 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT)

5.7.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-4
Test Voltage:	Power Line: 1 kV Signal Line: N/A
Polarity:	Positive & Negative
Impulse Frequency:	100 kHz: only for signal lines of xDSL equipment 5 kHz: except for xDSL equipment
Impulse Waveshape:	5/50 ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	1 min.

5.7.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Haefely, EFT Generator	PEFT 4010	154954	Apr. 16, 2014	Apr. 15, 2015
Haefely, Capacitive Clamp	IP4A	155173	Apr. 16, 2014	Apr. 15, 2015

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in EFT Room.
3. Tested Date: Apr. 10, 2015

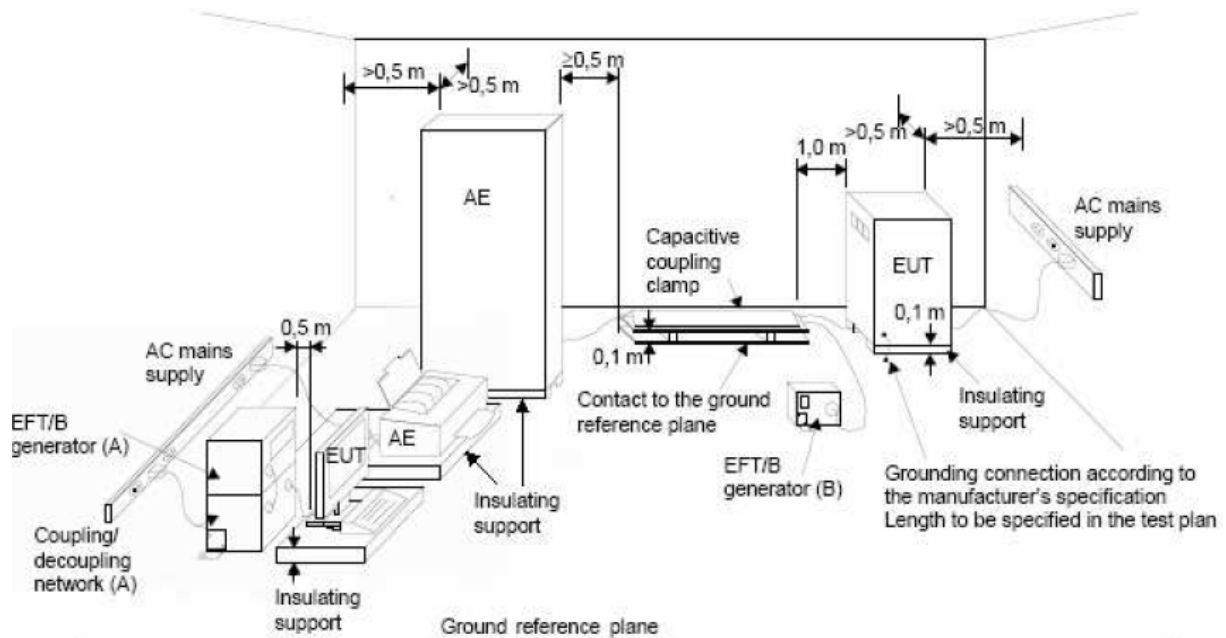
5.7.3 TEST PROEDURE

- Both positive and negative polarity discharges were applied.
- The distance between any coupling devices and the EUT should be (0.5 – 0/+0.1) m for table-top equipment testing, and (1.0 ± 0.1) m for floor standing equipment.
- The duration time of each test sequential was 1 minute.
- The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

5.7.4 DEVIATION FROM TEST STANDARD

No deviation

5.7.5 TEST SETUP



NOTE:

- (A) location for supply line coupling
- (B) location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

5.7.6 TEST RESULTS

TEST MODE	Mode 3	INPUT POWER	230Vac, 50Hz
ENVIRONMENTAL CONDITIONS	21 deg. C, 67% RH	TESTED BY:	Jiannren Hsieh

Test Point	Polarity	Test Level (kV)	Observation	Performance Criterion
L1	+/-	1	Note	A
L2	+/-	1	Note	A
PE	+/-	1	Note	A
L1-L2-PE	+/-	1	Note	A

NOTE: There was no change compared with initial operation during the test.

5.7.7 SURGE IMMUNITY TEST

5.7.8 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-5
Wave-Shape:	Combination Wave
	1.2/50 us Open Circuit Voltage
	8 /20 us Short Circuit Current
Test Voltage:	Power Line: 0.5kV/ 1kV/ 2kV
Generator Source	2 ohm between networks
Impedance:	12 ohm between network and ground
Polarity:	Positive/Negative
Phase Angle:	0° /90°/180°/270°
Pulse Repetition Rate:	1 time / 20 sec.
Number of Tests:	5 positive and 5 negative at selected points

5.7.9 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ, Surge Simulator	NSG 3060	1572	May 20, 2014	May 19, 2015
Coupling Decoupling Network	CDN-UTP8	028	Aug. 18, 2014	Aug. 17, 2015

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 2. The test was performed in EMS Room No. 2.
 3. Tested Date: Apr. 10, 2015.

5.7.10 TEST PROCEDURE

a. For EUT power supply:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:

The surge is applied to the lines via the capacitive coupling. The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

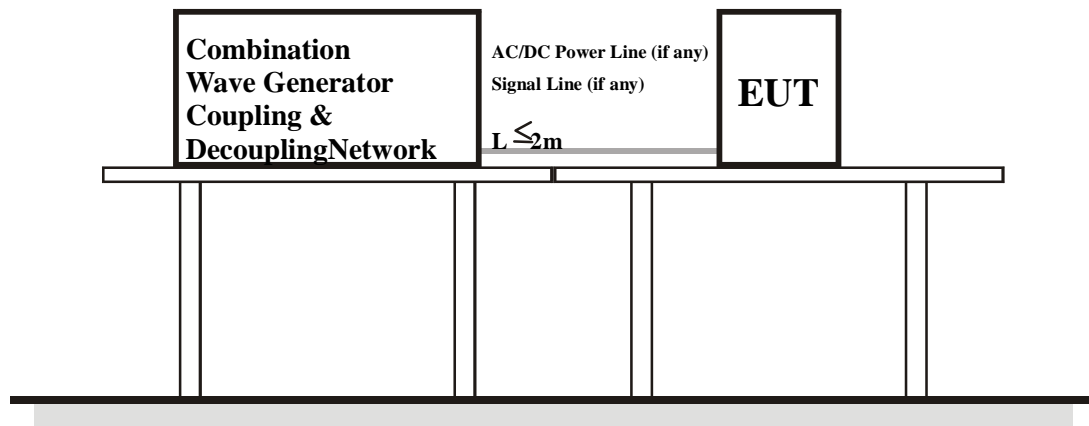
c. For test applied to unshielded symmetrically operated interconnection / telecommunication lines of EUT:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

5.7.11 DEVIATION FROM TEST STANDARD

No deviation

5.7.12 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

5.7.13 TEST RESULTS

TEST MODE	Mode 3	INPUT POWER	230Vac, 50Hz
ENVIRONMENTAL CONDITIONS	21 deg. C, 67% RH	TESTED BY: Jiannren Hsieh	

VOLTAGE (kV)	TEST POINT	POLARITY (+/-)	OBSERVATION	PERFORMANCE CRITERION
0.5, 1	L1-L2	+/-	Note	A
0.5, 1, 2	L1-PE	+/-	Note	A
0.5, 1, 2	L2-PE	+/-	Note	A

NOTE: There was no change compared with the initial operation during the test.

5.8 IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS (CS)

5.8.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Field Strength:	3 V _{r.m.s.}
Modulation:	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of fundamental
Coupling Device:	CDN-M3

5.8.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ Signal Generator	SML03	101801	Jan. 05, 2015	Jan. 04, 2016
Digital Sweep Function Generator	8120	984801	NA	NA
AR Power Amplifier	75A250AM1	312196	NA	NA
FCC Coupling Decoupling Network	FCC-801-M3-25A	48	Jun. 23, 2014	Jun. 22, 2015
FCC Coupling Decoupling Network	FCC-801-M3-25A	01022	Jun. 23, 2014	Jun. 22, 2015
FCC Coupling Decoupling Network	FCC-801-M2-16A	01047	Jun. 23, 2014	Jun. 22, 2015
FISCHER CUSTOM COMMUNICATIONS EM Injection Clamp	FCC-203I	50	NA	NA
FISCHER CUSTOM COMMUNICATIONS Current Injection Clamp	F-120-9A	361	NA	NA
EM TEST Coupling Decoupling Network	CDN M1/32A	306508	Jun. 23, 2014	Jun. 22, 2015
TESEQ Coupling Decoupling Network	CDN T800	34428	Jun. 23, 2014	Jun. 22, 2015
FCC Coupling Decoupling Network	FCC-801-T4	02031	Jun. 23, 2014	Jun. 22, 2015
FCC Coupling Decoupling Network	FCC-801-T2	02021	Jun. 23, 2014	Jun. 22, 2015
R&S Power Sensor	NRV-Z5	837878/039	Oct. 28, 2014	Oct. 27, 2015
R&S Power Meter	NRVD	837794/040	Oct. 28, 2014	Oct. 27, 2015
Software	ADT_CS_V7.4.2	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in CS Room No. 1.
3. Tested Date: Apr. 13, 2015.

5.8.3 TEST PROCEDURE

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50Ω , providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. The dwell time of the amplitude modulated carrier at each frequency shall not be less than the time necessary for the EUT to be exercised and to respond, but shall in no case be less than 0,5 s. The sensitive frequencies (e.g. clock frequencies) shall be analyzed separately.
- f. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

5.8.4 DEVIATION FROM TEST STANDARD

No deviation

IEC 1594/03

Report Format Version 6.1.0

5.8.6 TEST RESULTS

TEST MODE	Mode 3	INPUT POWER	230Vac, 50Hz
ENVIRONMENTAL CONDITIONS	22 deg. C, 69% RH	TESTED BY: Bernie Lu	

Frequency (MHz)	Field Strength (V _{r.m.s.})	Cable	Injection Method	Return Path	Observation	Performance Criterion
0.15 –80	3	AC power line	CDN-M3	N/A	Note	A

NOTE: There was no change compared with the initial operation during the test.

5.9 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

5.9.1 TEST SPECIFICATION

For EN 55024 only

Basic Standard:	IEC 61000-4-8
Frequency Range:	50 Hz
Field Strength:	1 A/m
Observation Time:	1 minute
Inductance Coil:	Rectangular type, 1 m x 1 m

5.9.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
HAEFELY Magnetic Field Tester	MAG 100	083794-06	NA	NA
COMBINOVA Magnetic Field Meter	MFM10	224	Apr. 28, 2014	Apr. 27, 2015

Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in EMS Room No. 1
3. Tested Date: Apr. 10, 2015.

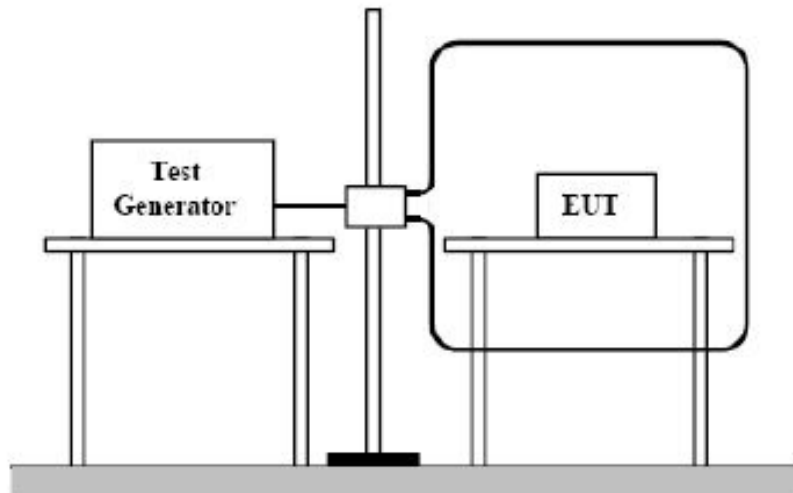
5.9.3 TEST PROCEDURE

- The equipment is configured and connected to satisfy its functional requirements.
- The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

5.9.4 DEVIATION FROM TEST STANDARD

No deviation

5.9.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

NOTE:

TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

5.9.6 TEST RESULTS

TEST MODE	Mode 3	INPUT POWER	230Vac, 50Hz
ENVIRONMENTAL CONDITIONS	21 deg. C, 69% RH	TESTED BY: Jiannren Hsieh	

Direction	Field Strength (A/m)	Observation	Performance Criterion
X - Axis	1	Note	A
Y - Axis	1	Note	A
Z - Axis	1	Note	A

NOTE: There was no change compared with the initial operation during the test.

5.10 VOLTAGE DIP/SHORT INTERRUPTIONS/VOLTAGE VARIATIONS (DIP) IMMUNITY TEST

5.10.1 TEST SPECIFICATION

Basic Standard:	IEC 61000-4-11
Test Duration Time:	Minimum three test events in sequence
Interval between Event:	Minimum ten seconds
Phase Angle:	0° & 180°
Test Cycle:	3 times

5.10.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Immunity Test System	Proflin 2145	1323A03998	Aug. 26, 2013	Aug. 25, 2015
Software	WIN2145	NA	NA	NA

Notes: 1. The calibration interval of the above test instruments is 24 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in EMS Room No. 2.
3. Tested Date: Apr. 10, 2015.

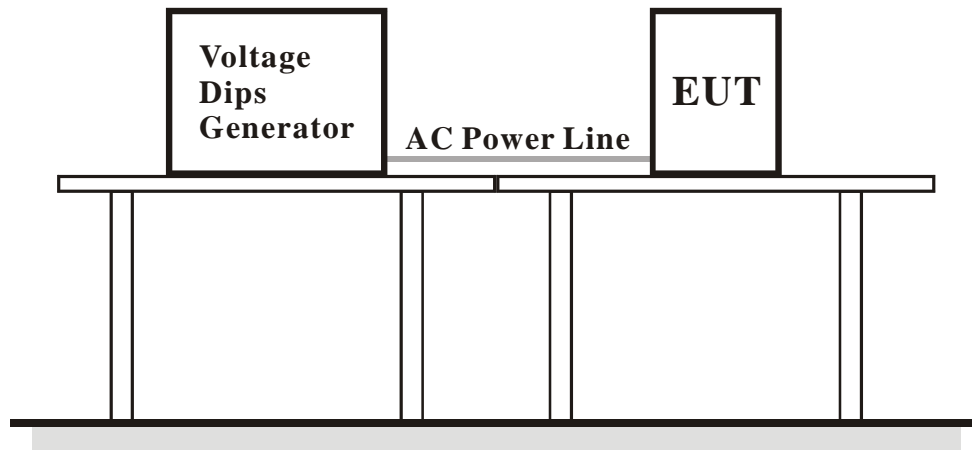
5.10.3 TEST PROCEDURE

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

5.10.4 DEVIATION FROM TEST STANDARD

No deviation

5.10.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

5.10.6 TEST RESULTS – FOR EN 61204-3

TEST MODE	Mode 3	INPUT POWER	230Vac, 50Hz, 100Vac, 50Hz, 240Vac, 50Hz
ENVIRONMENTAL CONDITIONS	21 deg. C, 67% RH	TESTED BY:	Jiannren Hsieh

Input Power for testing: 230 Vac, 50 Hz			
VOLTAGE % REDUCTION	DURATIONS (ms)	OBSERVATION	PERFORMANCE CRITERION
30	10	Note (1)	A
60	100	Note (1)	A
>95	5000	Note (2)	B

Input Power for testing: 100 Vac, 50 Hz			
VOLTAGE % REDUCTION	DURATIONS (ms)	OBSERVATION	PERFORMANCE CRITERION
30	10	Note (1)	A
60	100	Note (2)	B
>95	5000	Note (2)	B

Input Power for testing: 240 Vac, 50 Hz			
VOLTAGE % REDUCTION	DURATIONS (ms)	OBSERVATION	PERFORMANCE CRITERION
30	10	Note (1)	A
60	100	Note (1)	A
>95	5000	Note (2)	B

NOTE: (1) There was no change compared with the initial operation during the test.
(2) The EUT reset during the test.

5.10.7 TEST RESULTS – FOR EN 55024

TEST MODE	Mode 3	INPUT POWER	230Vac, 50 Hz/ 100Vac, 50 Hz/ 240Vac, 50 Hz
ENVIRONMENTAL CONDITIONS	21 deg. C, 67% RH	TESTED BY:	Jiannren Hsieh

Input Power for testing: 230Vac, 50 Hz			
VOLTAGE % REDUCTION	PERIODS	OBSERVATION	PERFORMANCE CRITERION
>95	0.5	Note (1)	A
30	25	Note (1)	A
>95	250	Note (2)	B

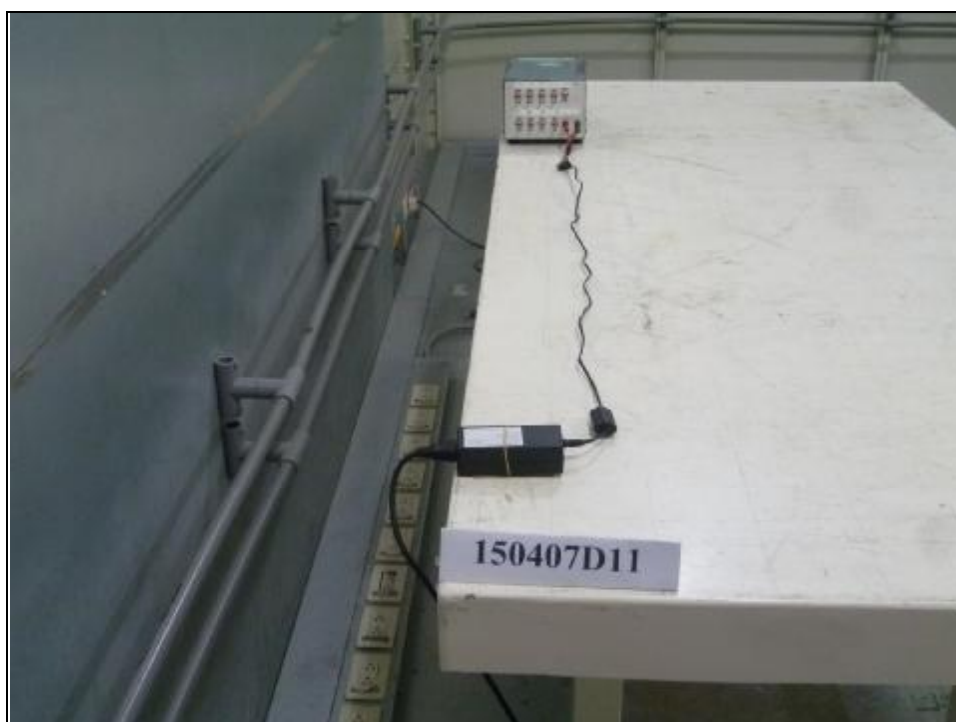
Input Power for testing: 100Vac, 50 Hz			
VOLTAGE % REDUCTION	PERIODS	OBSERVATION	PERFORMANCE CRITERION
>95	0.5	Note (1)	A
30	25	Note (1)	A
>95	250	Note (2)	B

Input Power for testing: 240Vac, 50 Hz			
VOLTAGE % REDUCTION	PERIODS	OBSERVATION	PERFORMANCE CRITERION
>95	0.5	Note (1)	A
30	25	Note (1)	A
>95	250	Note (2)	B

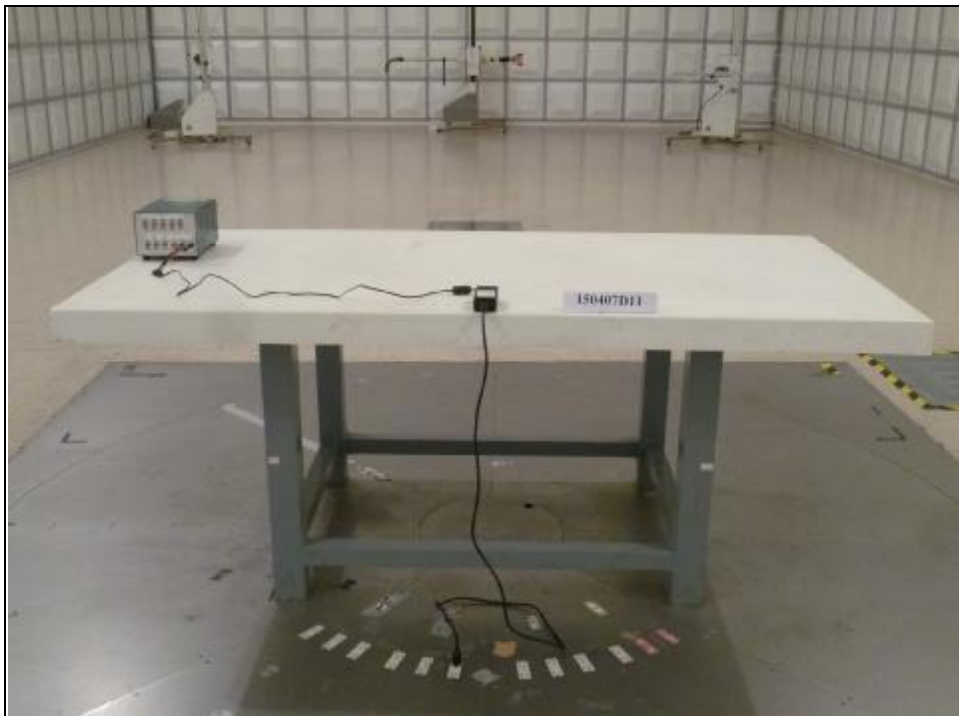
NOTE: (1) There was no change compared with the initial operation during the test.
(2) The EUT reset during the test.

6 PHOTOGRAPHS OF THE TEST CONFIGURATION

CONDUCTED EMISSION TEST



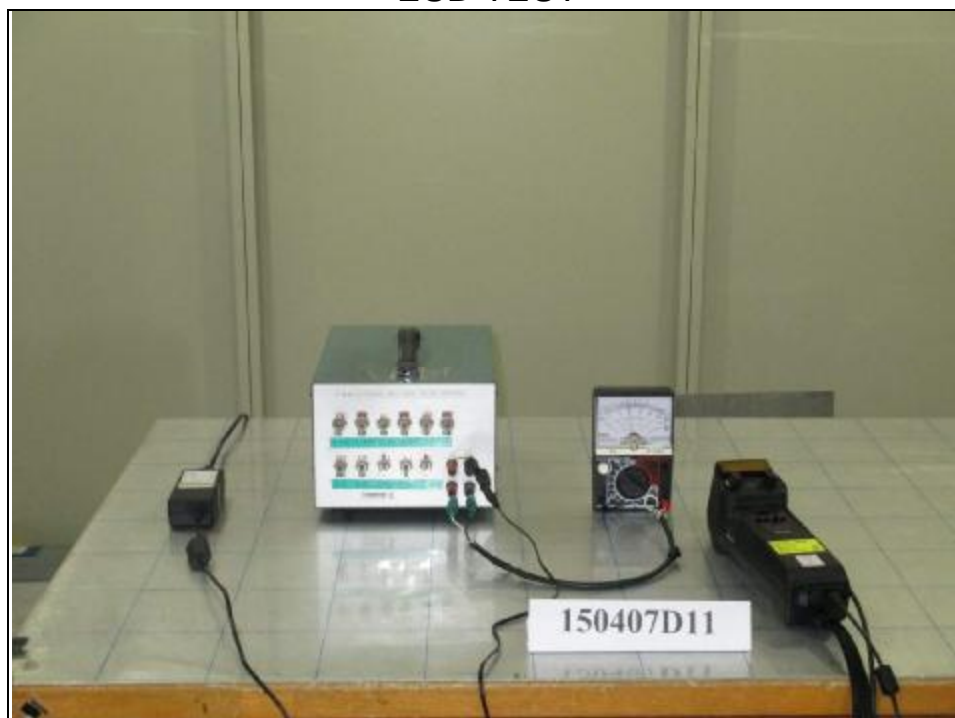
RADIATED EMISSION TEST



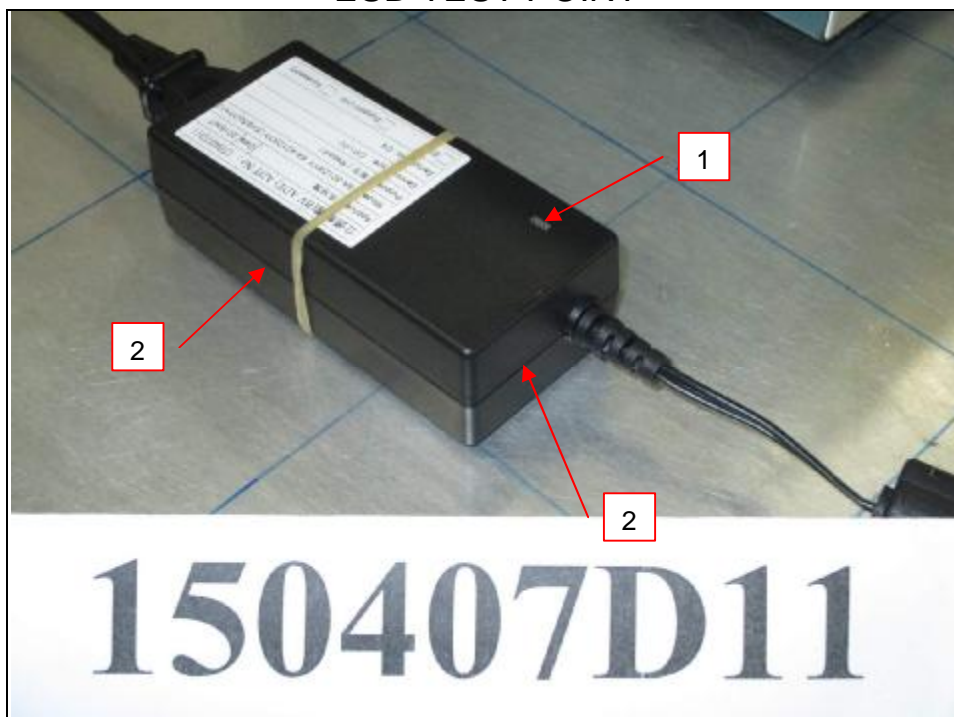
HARMONICS EMISSION TEST & VOLTAGE FLUCTUATIONS AND FLICKER TEST



ESD TEST

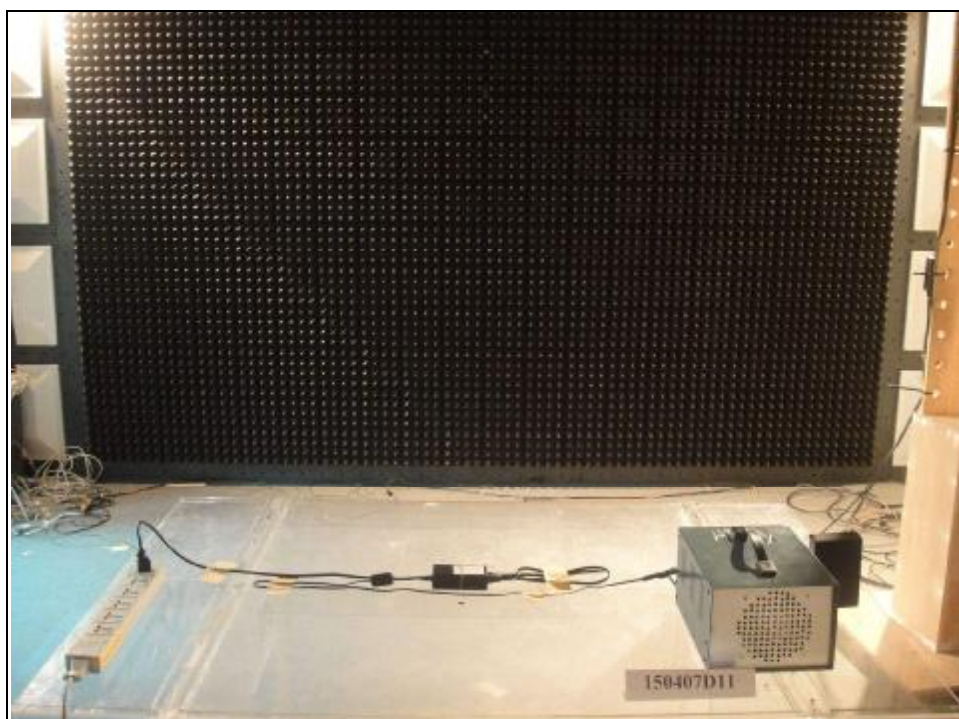


ESD TEST POINT





RS TEST



EFT TEST



SURGE TEST



VOLTAGE DIPS AND INTERRUPTIONS TEST



7 APPENDIX - INFORMATION ON THE TESTING LABORATORIES

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

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Web Site: www.bureauveritas-adt.com

The address and road map of all our labs can be found in our web site also.

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